General Description

The ICS879S216I-02 is a Differential-to-LVPECL/ LVDS Clock Divider which can operate up to 2.5GHz. ICS879S216I-02 has 2 selectable differential clock inputs. The fully differential architecture and low propagation delay make it ideal for use in clock distribution circuits. ICS879S216I-02 can divide the input clock by ÷2, ÷4, ÷8 and ÷16. Table 4A lists all the available output dividers.

Features

- High speed 2:2 differential divider
- Two differential LVPECL or LVDS output pairs
- Four selectable divide combinations
- PCLKx can accept the following input levels: LVPECL, LVDS, CML
- Maximum input frequency: 2.5GHz
- Propagation delay: 0.8ns (minimum), 1.6ns (maximum)
- Output Skew: 25ps (maximum)
- Full 3.3V or 2.5V supply modes
- -40°C to 85°C ambient operating temperature
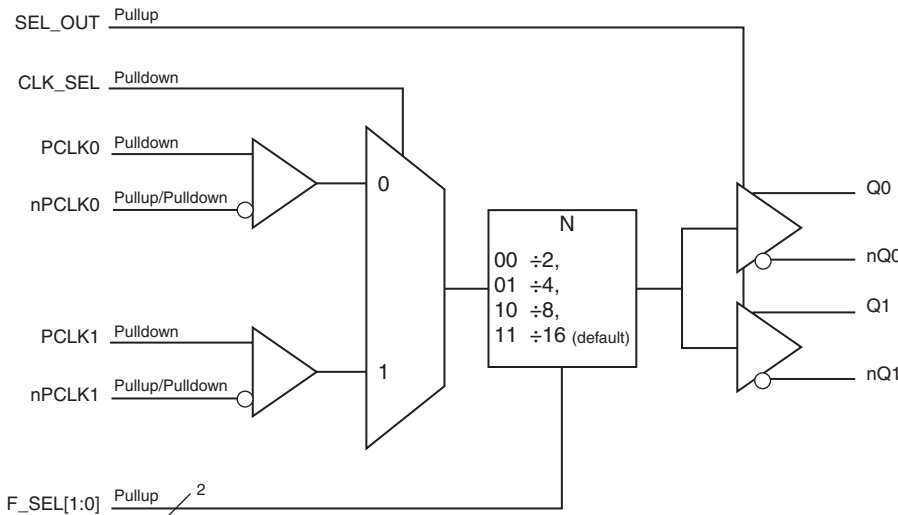- Available in lead-free (RoHS 5) package

Table 1A. V_{CC_TAP} Function Table

Outputs		
Q[1:0], nQ[1:0]	Output Level Supply	V_{CC_TAP}
LVPECL	2.5V	V_{CC}
LVPECL	3.3V	V_{CC}
LVDS	2.5V	V_{CC}
LVDS	3.3V	Float

Table 1B. SEL_OUT Function Table

Input	Outputs
SEL_OUT	Q[1:0], nQ[1:0]
1	LVPECL (default)
0	LVDS

Block Diagram

Pin Assignment
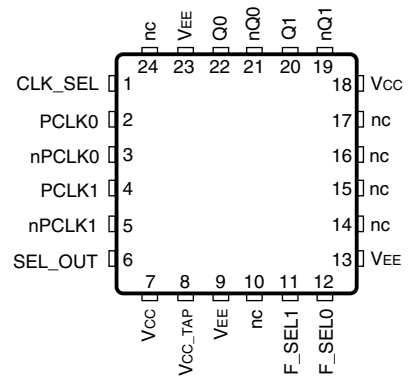
ICS879S216I-02

24-Lead VFQFN
4mm x 4mm x 0.95mm package body
K Package
Top View

Table 2. Pin Descriptions

Number	Name	Type		Description
1	CLK_SEL	Input	Pulldown	Clock select input. See Table 4B. LVCMOS/LVTTL interface levels.
2	PCLK0	Input	Pulldown	Non-inverting differential LVPECL clock input.
3	nPCLK0	Input	Pullup/Pulldown	Inverting differential LVPECL clock input.
4	PCLK1	Input	Pulldown	Non-inverting differential LVPECL clock input.
5	nPCLK1	Input	Pullup/Pulldown	Inverting differential LVPECL clock input.
6	SEL_OUT	Input	Pullup	Select pin. See Table 1B. LVCMOS/LVTTL interface levels.
7, 18	V_{CC}	Power		Power supply pins.
8	V_{CC_TAP}	Power		Power supply pin. See Table 1A.
9, 13, 23	V_{EE}	Power		Negative supply pins.
10, 14. 15, 16, 17, 24	nc	Unused		No connect.
11, 12	F_SEL1, F_SEL0	Input	Pullup	Clock select inputs. See Table 4A. LVCMOS / LVTTL interface levels.
19, 20	nQ1, Q1	Output		Differential output pair. LVPECL or LVDS interface levels.
21, 22	nQ0, Q0	Output		Differential output pair. LVPECL or LVDS interface levels.

NOTE: *Pullup and Pulldown* refer to internal input resistors. See Table 2, *Pin Characteristics,* for typical values.

Table 3. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance			2		pF
R_{PULLUP}	Input Pullup Resistor			51		kΩ
$R_{PULLDOWN}$	Input Pulldown Resistor			51		kΩ

Function Tables

Table 4A. Clock Input Function Table

Input		Divide
F_SEL1	F_SEL0	
0	0	2
0	1	4
1	0	8
1	1	16 (default)

Table 4B. CLK_SEL Function Table

Inputs	
CLK_SEL	PCLK[0:1], nPCLK[0:1]
0	PCLK0, nPCLK0 (default)
1	PCLK1, nPCLK1

NOTE: CLK_SEL is an asynchronous control.

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V_{CC}	4.6V
Inputs, V_I	-0.5V to V_{CC} + 0.5V
Outputs, I_O (LVPECL) Continuous Current Surge Current Outputs, I_O (LVDS) Continuos Current Surge Current	50mA 100mA 10mA 15mA
Package Thermal Impedance, θ_{JA}	49.5°C/W (0 mps)
Storage Temperature, T_{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 5A. LVPECL Power Supply DC Characteristics, $V_{CC} = V_{CC\_TAP} = 3.3V \pm 5\%$, $V_{EE} = 0V$, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Power Supply Voltage		3.135	3.3	3.465	V
V_{CC_TAP}	Power Supply Voltage		3.135	3.3	3.465	V
I_{EE}	Power Supply Current				65	mA

Table 5B. LVPECL Power Supply DC Characteristics, $V_{CC} = V_{CC\_TAP} = 2.5V \pm 5\%$, $V_{EE} = 0V$, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Power Supply Voltage		2.375	2.5	2.625	V
V_{CC_TAP}	Power Supply Voltage		2.375	2.5	2.625	V
I_{EE}	Power Supply Current				60	mA

Table 5C. LVDS Power Supply DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, V_{CC_TAP} = Float, $V_{EE} = 0V$, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Positive Supply Voltage		3.135	3.3	3.465	V
I_{EE}	Power Supply Current				95	mA

Table 5D. LVDS Power Supply DC Characteristics, $V_{CC} = V_{CC\_TAP} = 2.5V \pm 5\%$, $V_{EE} = 0V$, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{CC}	Power Supply Voltage		2.375	2.5	2.625	V
V_{CC_TAP}	Power Supply Voltage		2.375	2.5	2.625	V
I_{EE}	Power Supply Current				90	mA

Table 5E. LVCMOS/LVTTL DC Characteristics, $V_{CC} = V_{CC\_TAP} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage		$V_{CC} = 3.465V$	2.2		$V_{CC} + 0.3$	V
			$V_{CC} = 2.625V$	1.7		$V_{CC} + 0.3$	V
V_{IL}	Input Low Voltage		$V_{CC} = 3.465V$	-0.3		0.8	V
			$V_{CC} = 2.625V$	-0.3		0.7	V
I_{IH}	Input High Current	CLK_SEL	$V_{CC} = V_{IN} = 3.465V$ or $2.625V$			150	µA
		F_SEL[1:0], SEL_OUT	$V_{CC} = V_{IN} = 3.465V$ or $2.625V$			10	µA
I_{IL}	Input Low Current	CLK_SEL	$V_{CC} = 3.465V$ or $2.625V$, $V_{IN} = 0V$	-10			µA
		F_SEL[1:0], SEL_OUT	$V_{CC} = 3.465V$ or $2.625V$, $V_{IN} = 0V$	-150			µA

Table 5F. LVPECL DC Characteristics, $V_{CC} = V_{CC\_TAP} = 3.3V \pm 5\%$ or $2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
I_{IH}	Input High Current	PCLK0, nPCLK0, PCLK1, nPCLK1	$V_{CC} = V_{IN} = 3.465V$ or $2.625V$			150	µA
I_{IL}	Input Low Current	PCLK0, PCLK1	$V_{CC} = 3.465V$ or $2.625V$	-10			µA
		nPCLK0, nPCLK1	$V_{CC} = 3.465V$ or $2.625V$, $V_{IN} = 0V$	-150			µA
V_{PP}	Peak-to-Peak Voltage; NOTE 1			0.15		1.3	V
V_{CMR}	Common Mode Input Voltage; NOTE 1, 2			$V_{EE} + 0.5$		$V_{CC} - 0.85$	V
V_{OH}	Output High Voltage; NOTE 3			$V_{CC} - 1.4$		$V_{CC} - 0.8$	V
V_{OL}	Output Low Voltage; NOTE 3			$V_{CC} - 2.0$		$V_{CC} - 1.6$	V
V_{SWING}	Peak-to-Peak Output Voltage Swing			0.6		1.0	V

NOTE 1: V_{IL} should not be less than -0.3V.
NOTE 2: Common mode input voltage is defined as V_{IH}.
NOTE 3: Outputs terminated with 50Ω to $V_{CC} - 2V$.

Table 5G. LVDS DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, V_{CC_TAP} = Float, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OD}	Differential Output Voltage	SEL_OUT = 0	247		454	mV
ΔV_{OD}	V_{OD} Magnitude Change	SEL_OUT = 0			50	mV
V_{OS}	Offset Voltage	SEL_OUT = 0	1.125		1.375	V
ΔV_{OS}	V_{OS} Magnitude Change	SEL_OUT = 0			50	mV

Table 5H. LVDS DC Characteristics, $V_{CC} = V_{CC\_TAP} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OD}	Differential Output Voltage	SEL_OUT = 0	247		454	mV
ΔV_{OD}	V_{OD} Magnitude Change	SEL_OUT = 0			50	mV
V_{OS}	Offset Voltage	SEL_OUT = 0	1.1		1.375	V
ΔV_{OS}	V_{OS} Magnitude Change	SEL_OUT = 0			50	mV

AC Electrical Characteristics

Table 6A. LVPECL AC Characteristics, $V_{CC} = V_{CC\_TAP} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{IN}	Input Frequency				2.5	GHz
f_{OUT}	Output Frequency	F_SEL[1:0] = 00			1.25	GHz
		F_SEL[1:0] = 01			625	MHz
		F_SEL[1:0] = 10			312.5	MHz
		F_SEL[1:0] = 11			156.25	MHz
tp_{LH}	Propagation Delay, Low-to-High; NOTE 1		0.8		1.6	ns
$t$sk(i)	Input Skew				60	ps
$t$sk(o)	Output Skew; NOTE 2, 3				25	ps
$t$sk(pp)	Part-to-Part Skew; NOTE 2; 4				650	ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	90		250	ps
odc	Output Duty Cycle		47		53	%
$MUX_{ISOLATION}$	MUX Isolation; NOTE 5			>100		dB

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
NOTE 1: Measured from the differential input crossing point to the differential output crossing point.
NOTE 2: This parameter is defined according with JEDEC Standard 65.
NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltage, same temperature, same frequency and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.
NOTE 4: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential output crossing point.
NOTE 5: Q, nQ outputs measured differentially. See *MUX Isolation diagram* in the Parameter Measurement Information Section.

**Table 6B. LVPECL AC Characteristics,** $V_{CC} = V_{CC\_TAP} = 2.5V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40°C$ to $85°C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{IN}	Input Frequency				2.5	GHz
f_{OUT}	Output Frequency	F_SEL[1:0] = 00			1.25	GHz
		F_SEL[1:0] = 01			625	MHz
		F_SEL[1:0] = 10			312.5	MHz
		F_SEL[1:0] = 11			156.25	MHz
tp_{LH}	Propagation Delay, Low-to-High; NOTE 1		0.8		1.6	ns
$t$sk(i)	Input Skew				60	ps
$t$sk(o)	Output Skew; NOTE 2, 3				25	ps
$t$sk(pp)	Part-to-Part Skew; NOTE 2; 4				650	ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	90		250	ps
odc	Output Duty Cycle		47		53	%
$MUX_{ISOLATION}$	MUX Isolation			>100		dB

For NOTES, see Table 6A above.

Table 6C. LVDS AC Characteristics, V_{CC} = 3.3V ± 5%, V_{CC_TAP} = Float, V_{EE} = 0V, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{IN}	Input Frequency				2.5	GHz
f_{OUT}	Output Frequency	F_SEL[1:0] = 00			1.25	GHz
		F_SEL[1:0] = 01			625	MHz
		F_SEL[1:0] = 10			312.5	MHz
		F_SEL[1:0] = 11			156.25	MHz
tp_{LH}	Propagation Delay, Low-to-High; NOTE 1		0.8		1.6	ns
$t$sk(i)	Input Skew				75	ps
$t$sk(o)	Output Skew; NOTE 2, 3				25	ps
$t$sk(pp)	Part-to-Part Skew; NOTE 2; 4				650	ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	70		250	ps
odc	Output Duty Cycle		46		54	%
$MUX_{ISOLATION}$	MUX Isolation			>100		dB

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
NOTE 1: Measured from the differential input crossing point to the differential output crossing point.
NOTE 2: This parameter is defined according with JEDEC Standard 65.
NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltage, same temperature, same frequency and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.
NOTE 4: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential output crossing point.
NOTE 5: Q, nQ outputs measured differentially. See *MUX Isolation diagram* in the Parameter Measurement Information Section..

Table 6D. LVDS AC Characteristics, V_{CC} = V_{CC_TAP} = 2.5V ± 5%, V_{EE} = 0V, T_A = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f_{IN}	Input Frequency				2.5	GHz
f_{OUT}	Output Frequency	F_SEL[1:0] = 00			1.25	GHz
		F_SEL[1:0] = 01			625	MHz
		F_SEL[1:0] = 10			312.5	MHz
		F_SEL[1:0] = 11			156.25	MHz
tp_{LH}	Propagation Delay, Low-to-High; NOTE 1		0.8		1.6	ns
$t$sk(i)	Input Skew				75	ps
$t$sk(o)	Output Skew; NOTE 2, 3				25	ps
$t$sk(pp)	Part-to-Part Skew; NOTE 2; 4				650	ps
t_R / t_F	Output Rise/Fall Time	20% to 80%	70		250	ps
odc	Output Duty Cycle		46		54	%
$MUX_{ISOLATION}$	MUX Isolation			>100		dB

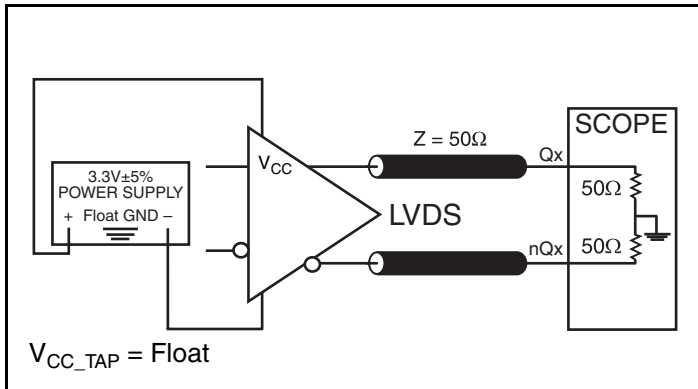For NOTES, see Table 6C above.

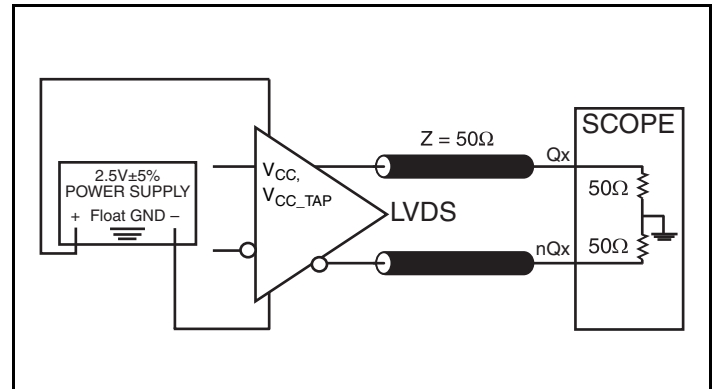# Parameter Measurement Information
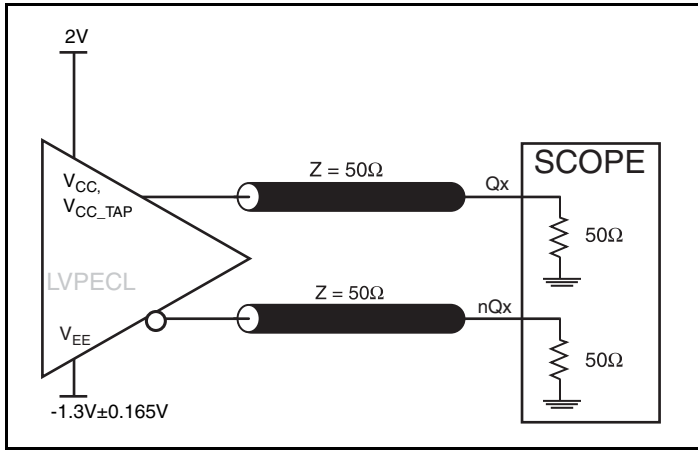
3.3V LVPECL Output Load AC Test Circuit
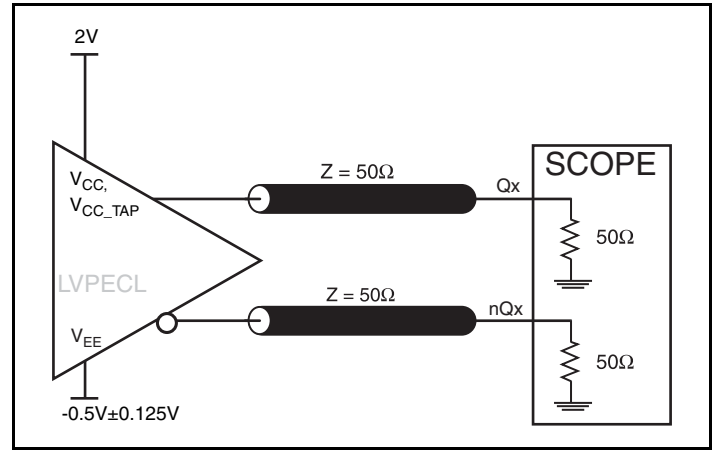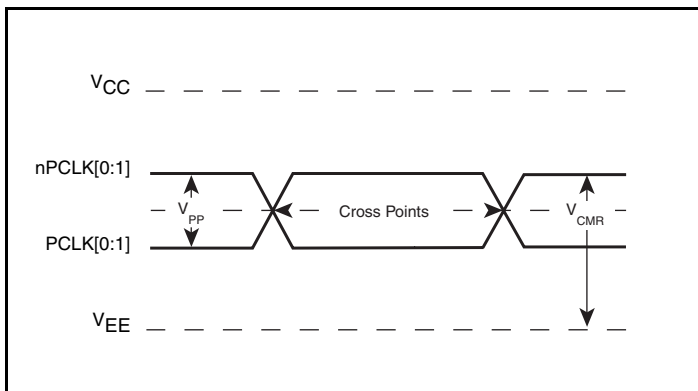

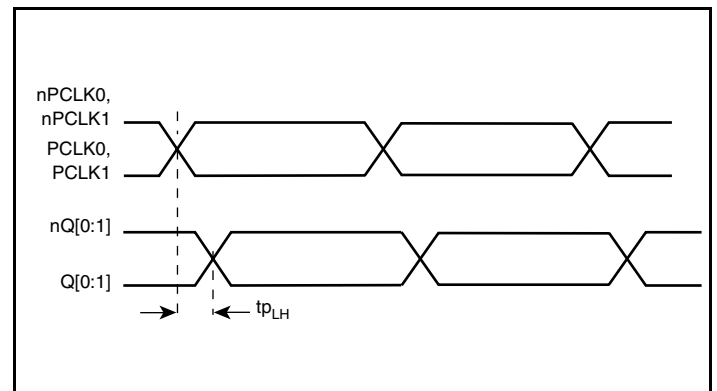**2.5V LVPECL Output Load AC Test Circuit**

3.3V LVDS Output Load AC Test Circuit
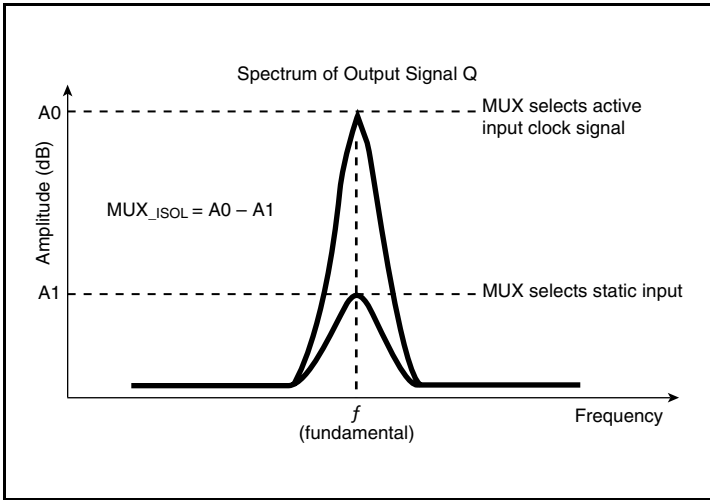

2.5V LVDS Output Load AC Test Circuit
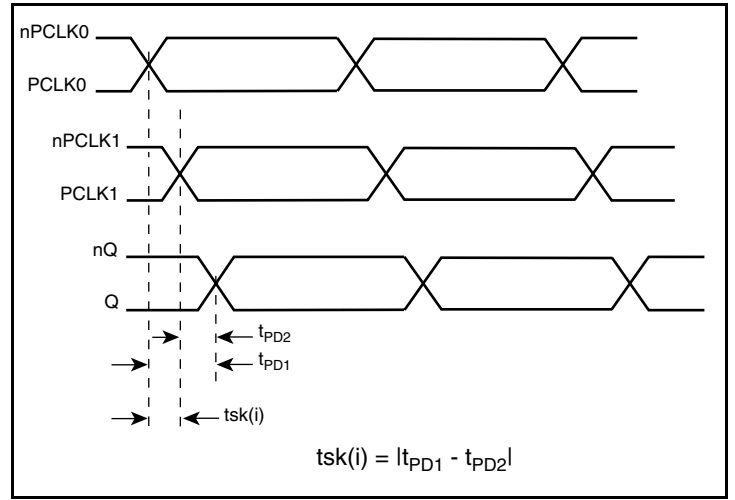

Differential Input Level

Propagation Delay

Parameter Measurement Information, continued

MUX Isolation

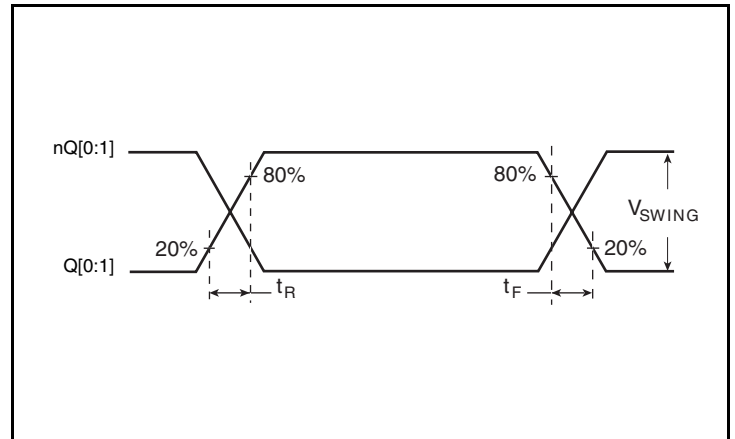$$\text{tsk(i)} = |t_{PD1} - t_{PD2}|$$
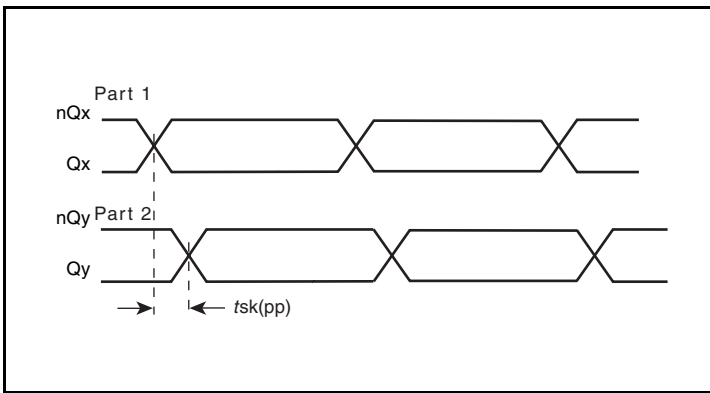
Input Skew

Part-to-Part Skew
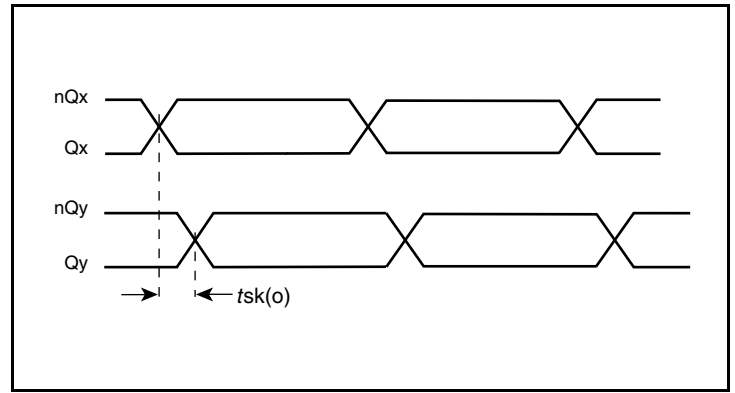
Output Skew
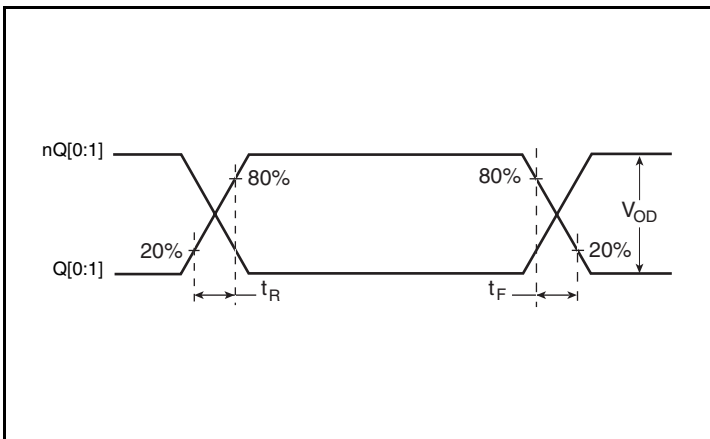
LVDS Output Rise/Fall Time

LVPECL Output Rise/Fall Time

Parameter Measurement Information, continued
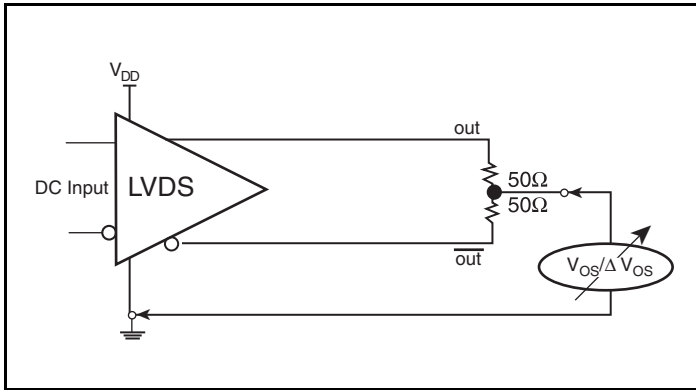
Offset Voltage Setup
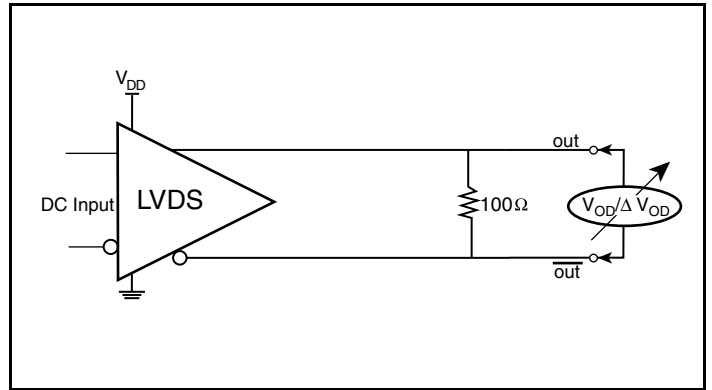
Differential Output Voltage Setup

$$odc = \frac{t_{PW}}{t_{PERIOD}} \times 100\%$$
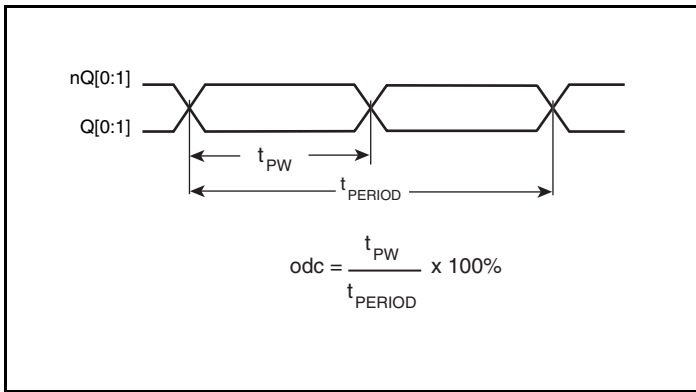
Output Duty Cycle/Pulse Width/Period

Applications Information

Recommendations for Unused Input and Output Pins

Inputs:

PCLK/nPCLK Inputs

For applications not requiring the use of a differential input, both the PCLK and nPCLK pins can be left floating. Though not required, but for additional protection, a 1kΩ resistor can be tied from PCLK to ground.

LVCMOS Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A 1kΩ resistor can be used.

Outputs:

LVPECL Outputs

All unused LVPECL outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

LVDS Outputs

All unused LVDS output pairs can be either left floating or terminated with 100Ω across. If they are left floating, there should be no trace attached.

Wiring the Differential Input to Accept Single-Ended Levels

Figure 1 shows how a differential input can be wired to accept single ended levels. The reference voltage $V_{REF} = V_{CC}/2$ is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the V_{REF} in the center of the input voltage swing. For example, if the input clock swing is 2.5V and $V_{CC} = 3.3V$, R1 and R2 value should be adjusted to set V_{REF} at 1.25V. The values below are for when both the single ended swing and V_{CC} are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission

line impedance. For most 50Ω applications, R3 and R4 can be 100Ω. The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however V_{IL} cannot be less than -0.3V and V_{IH} cannot be more than $V_{CC} + 0.3V$. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.
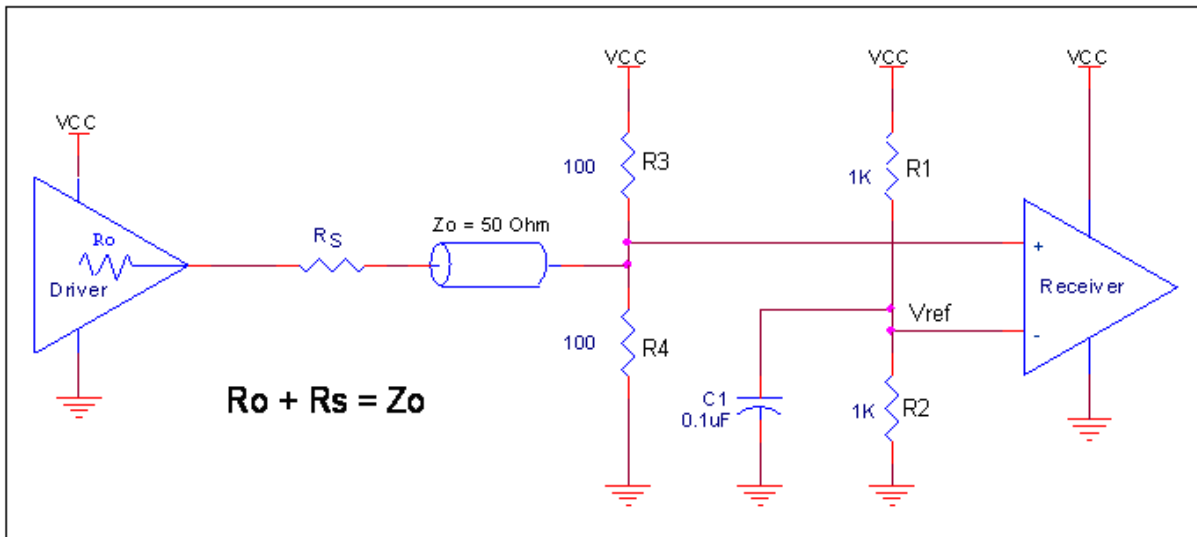

Figure 1. Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels

3.3V LVPECL Clock Input Interface

The PCLK /nPCLK accepts LVPECL, LVDS, CML and other differential signals. The differential signals must meet the V_{PP} and V_{CMR} input requirements. *Figures 2A to 2E* show interface examples for the PCLK/ nPCLK input driven by the most common driver types.

The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.
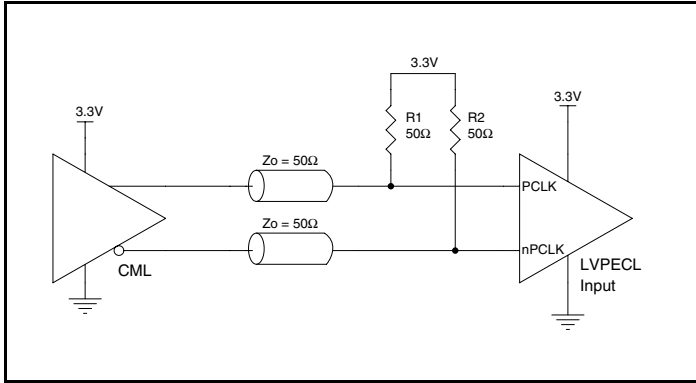
Figure 2A. PCLK/nPCLK Input Driven by a CML Driver
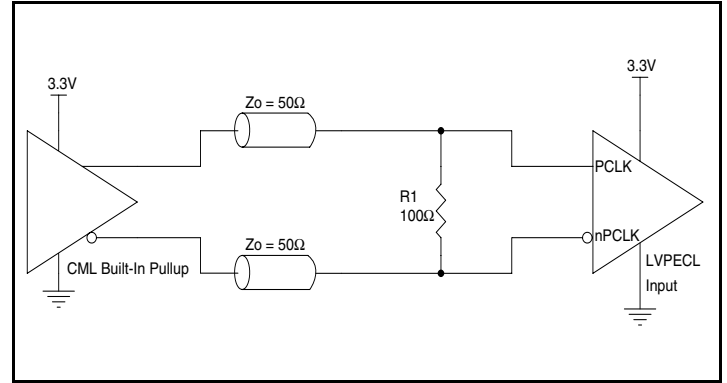
Figure 2B. PCLK/nPCLK Input Driven by a Built-In Pullup CML Driver
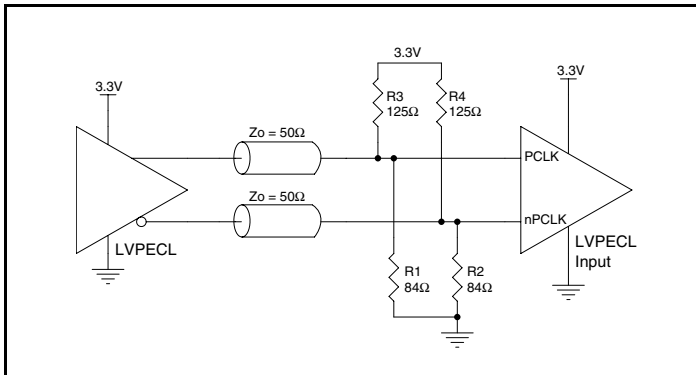
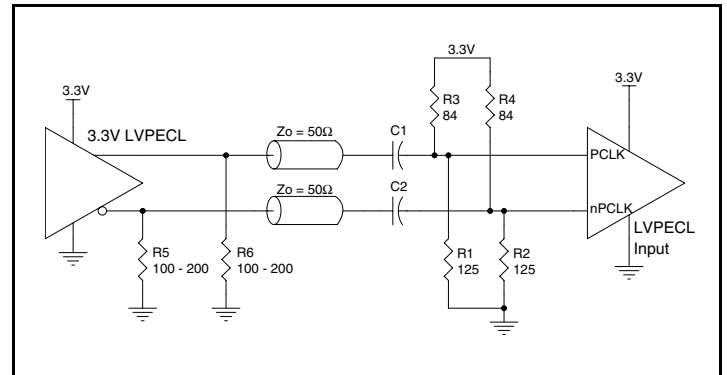**Figure 2C. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver**

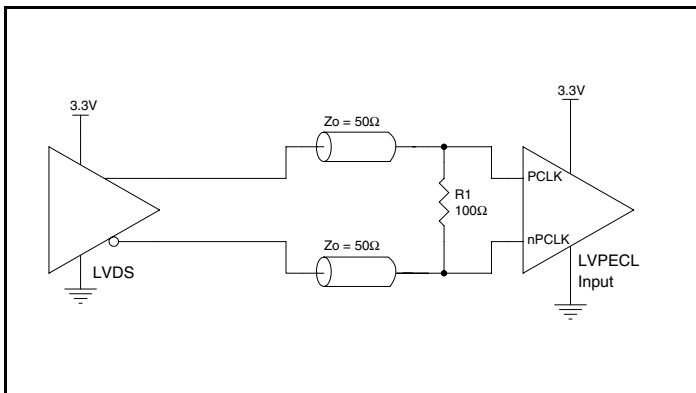**Figure 2D. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver with AC Couple**

Figure 2E. PCLK/nPCLK Input Driven by a 3.3V LVDS Driver

2.5V LVPECL Clock Input Interface

The PCLK /nPCLK accepts LVPECL, LVDS and other differential signals. The differential signals must meet the V_{PP} and V_{CMR} input requirements. *Figures 3A to 3C* show interface examples for the PCLK/nPCLK input driven by the most common driver types. The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.
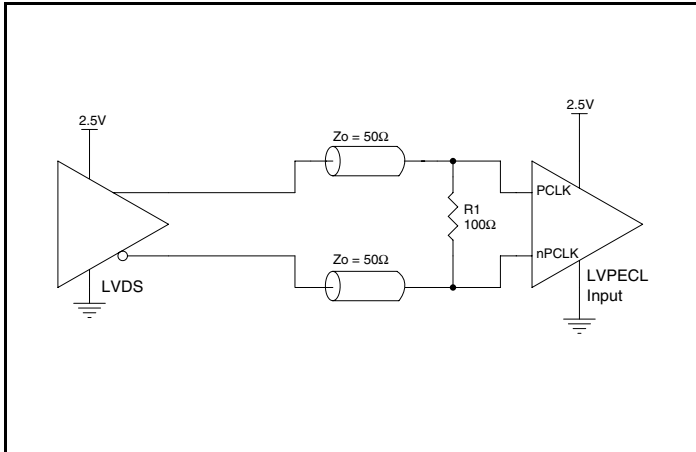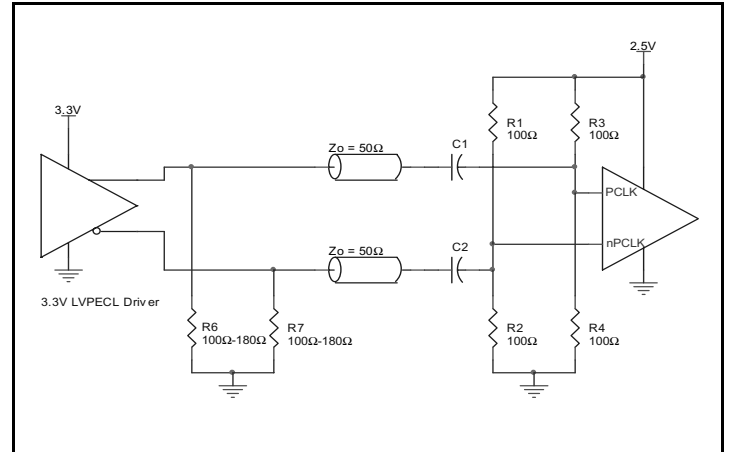
Figure 3A. PCLK/nPCLK Input Driven by a 2.5V LVDS Driver

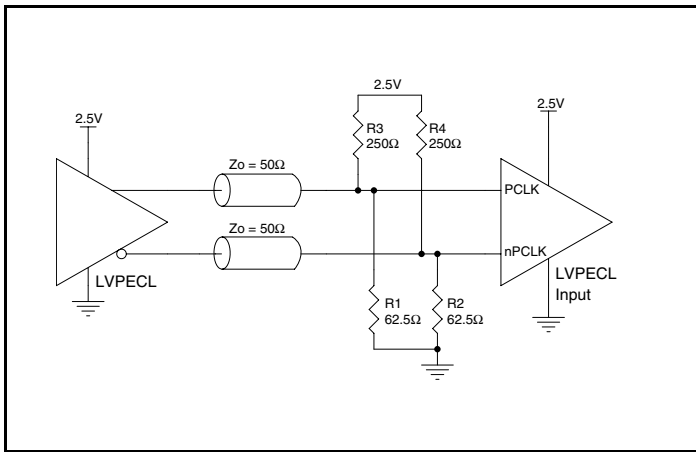**Figure 3B. PCLK/nPCLK Input Driven by a 3.3V LVPECL Driver with AC Couple**

Figure 3C. PCLK/nPCLK Input Driven by a 2.5V LVPECL Driver

LVDS Driver Termination

A general LVDS interface is shown in *Figure 4.* Standard termination for LVDS type output structure requires both a 100Ω parallel resistor at the receiver and a 100Ω differential transmission line environment. In order to avoid any transmission line reflection issues, the 100Ω resistor must be placed as close to the receiver as possible. IDT offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard termination schematic as shown in Figure 4 can be used with either type of output structure. If using a non-standard termination, it is recommended to contact IDT and confirm if the output is a current source or a voltage source type structure. In addition, since these outputs are LVDS compatible, the amplitude and common mode input range of the input receivers should be verified for compatibility with the output.
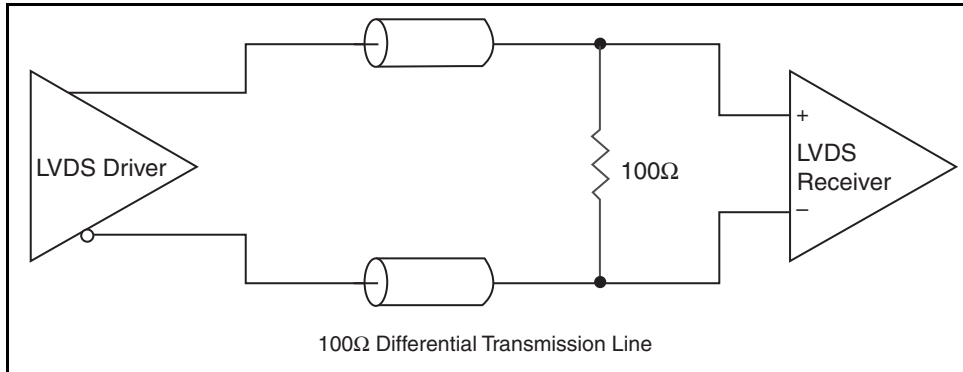

Figure 4. Typical LVDS Driver Termination

Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 5A and 5B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.
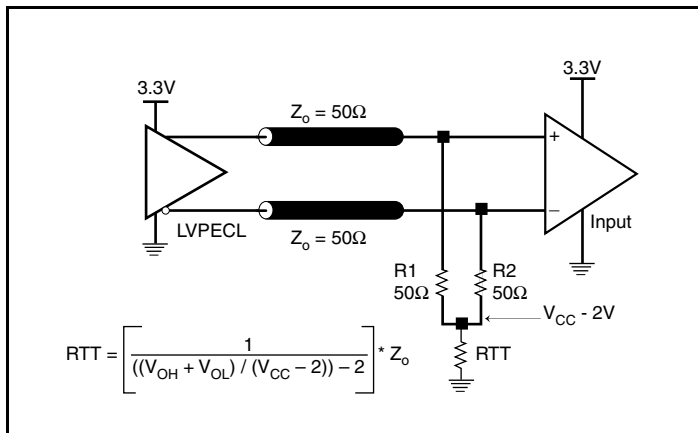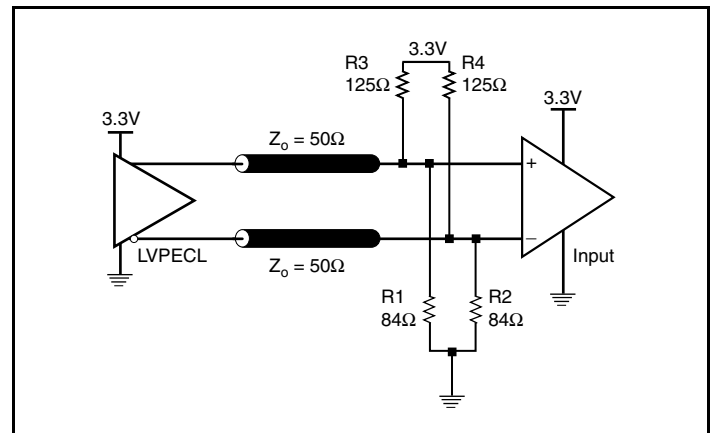

Figure 5A. 3.3V LVPECL Output Termination

Figure 5B. 3.3V LVPECL Output Termination

Termination for 2.5V LVPECL Outputs

Figure 6A and *Figure 5B* show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating 50Ω to V_{CC} – 2V. For V_{CC} = 2.5V, the V_{CC} – 2V is very close to ground level. The R3 in Figure 6B can be eliminated and the termination is shown in *Figure 6C*.
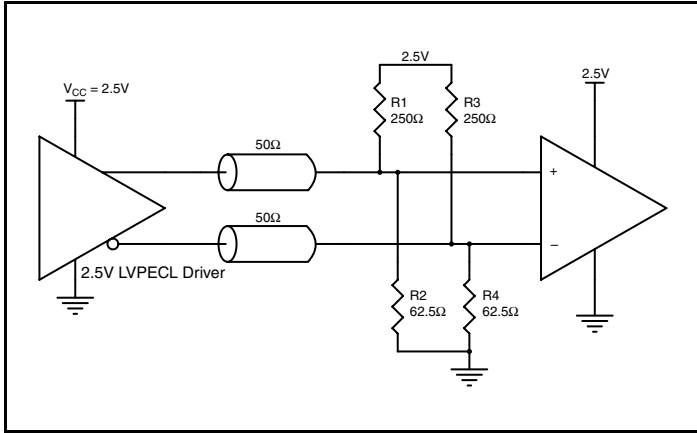
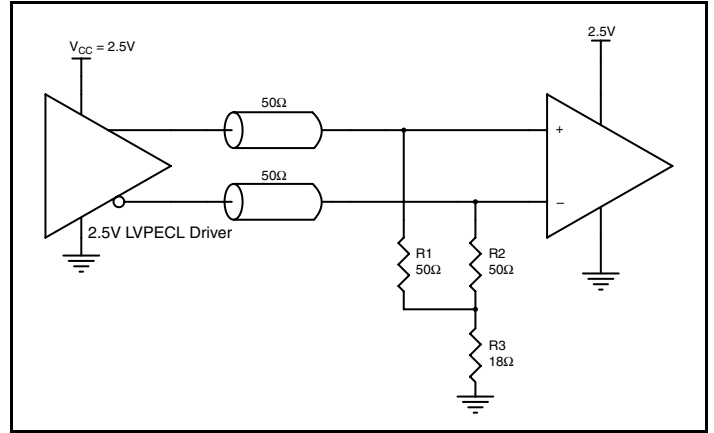**Figure 6A. 2.5V LVPECL Driver Termination Example**

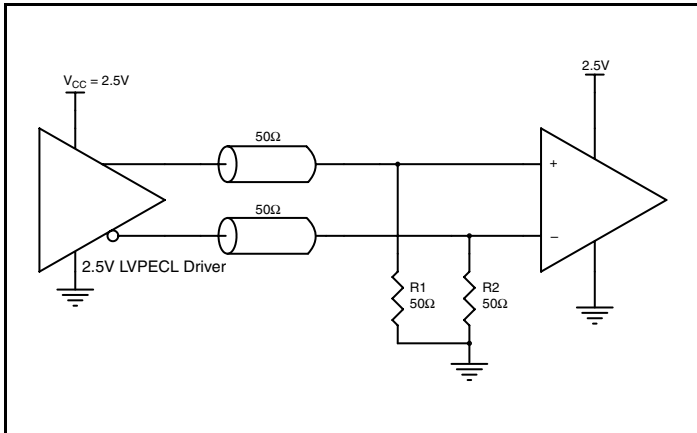**Figure 6B. 2.5V LVPECL Driver Termination Example**

Figure 6C. 2.5V LVPECL Driver Termination Example

VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 7.* The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific

and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Leadframe Base Package, Amkor Technology.
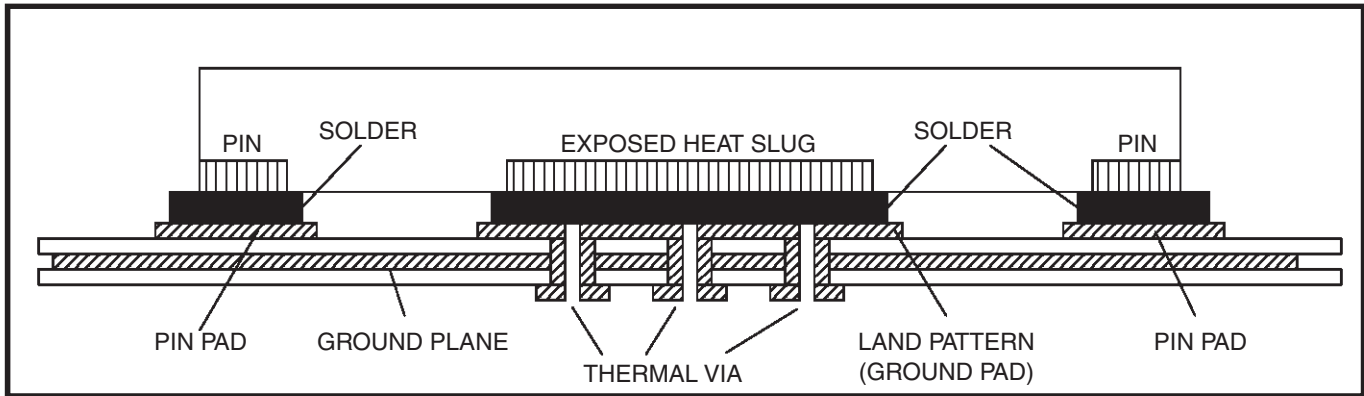

Figure 7. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale

LVPECL Power Considerations

This section provides information on power dissipation and junction temperature for the ICS879S2162I-02.
Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the ICS879S216I-02 is the sum of the core power plus the power dissipated in the load(s).
The following is the power dissipation for V_{CC} = 3.3V + 5% = 3.465V, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)$_{MAX}$ = V_{CC_MAX} * I_{EE_MAX} = 3.465V * 65mA = **225.225mW**

- Power (outputs)$_{MAX}$ = **32mW/Loaded Output pair**
  If all outputs are loaded, the total power is 2 * 32mW = **64mW**

Total Power$_{\_MAX}$ (3.465, with all outputs switching) = 225.225mW + 64mW = **289.225mW**

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

Tj = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 49.5°C/W per Table 7 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

85°C + 0.289W * 49.5°C/W = 99.3°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 7. Thermal Resistance θ_{JA} for 24 Lead VFQFN, Forced Convection

θ_{JA} by Velocity			
Meters per Second	**0**	**1**	**2.5**
Multi-Layer PCB, JEDEC Standard Test Boards	49.5°C/W	43.3°C/W	38.8°C/W

3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the LVPECL output pair.

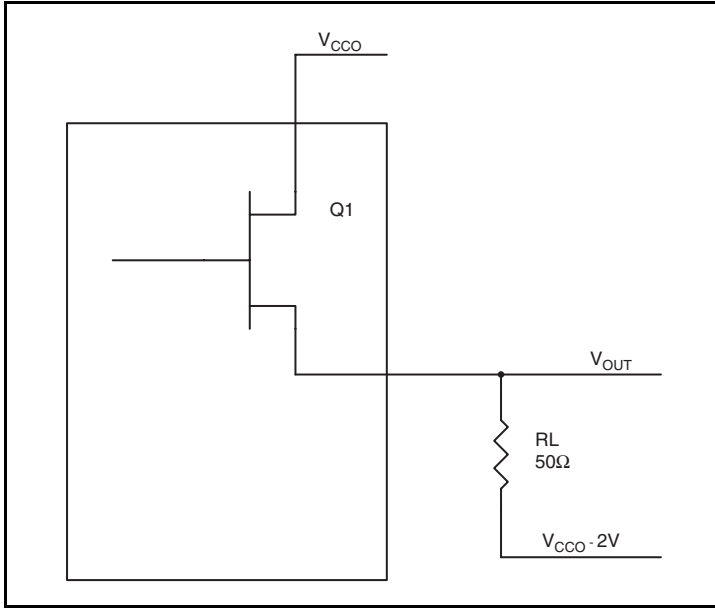LVPECL output driver circuit and termination are shown in *Figure 8.*

Figure 8. LVPECL Driver Circuit and Termination

To calculate worst case power dissipation into the load, use the following equations which assume a 50Ω load, and a termination voltage of $V_{CC} - 2V$.

- For logic high, $V_{OUT} = V_{OH\_MAX} = \mathbf{V_{CC\_MAX}} - \mathbf{0.8V}$
  $(V_{CC\_MAX} - V_{OH\_MAX}) = \mathbf{0.8V}$

- For logic low, $V_{OUT} = V_{OL\_MAX} = \mathbf{V_{CC\_MAX}} - \mathbf{1.6V}$
  $(V_{CC\_MAX} - V_{OL\_MAX}) = \mathbf{1.6V}$

Pd_H is power dissipation when the output drives high.

Pd_L is the power dissipation when the output drives low.

Pd_H = $[(V_{OH\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OH\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OH\_MAX}) =$
$[(2V - 0.8V)/50Ω] * 0.8V = \mathbf{19.2mW}$

Pd_L = $[(V_{OL\_MAX} - (V_{CC\_MAX} - 2V))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) = [(2V - (V_{CC\_MAX} - V_{OL\_MAX}))/R_L] * (V_{CC\_MAX} - V_{OL\_MAX}) =$
$[(2V - 1.6V)/50Ω] * 1.6V = \mathbf{12.8mW}$

Total Power Dissipation per output pair = Pd_H + Pd_L = **32mW**

LVDS Power Considerations

This section provides information on power dissipation and junction temperature for the ICS879S2162I-02.
Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the ICS879S2162I-02 is the sum of the core power plus the analog power plus the power dissipated in the load(s). The following is the power dissipation for V_{CC} = 3.3V + 5% = 3.465V, which gives worst case results.

- Power $(core)_{MAX}$ = V_{CC_MAX} * I_{EE_MAX} = 3.465V * 95mA = **329.175mW**

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: $Tj = \theta_{JA} * Pd\_total + T_A$

Tj = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 49.5°C/W per Table 8 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

85°C + 0.329W * 49.5°C/W = 101.3°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 8. Thermal Resistance θ_{JA} for 24 Lead VFQFN, Forced Convection

θ_{JA} by Velocity			
Meters per Second	**0**	**1**	**2.5**
Multi-Layer PCB, JEDEC Standard Test Boards	49.5°C/W	43.3°C/W	38.8°C/W

Reliability Information

Table 9. θ_{JA} **vs. Air Flow Table for a 24 Lead VFQFN**

θ_{JA} vs. Air Flow			
Meters per Second	**0**	**1**	**2.5**
Multi-Layer PCB, JEDEC Standard Test Boards	49.5°C/W	43.3°C/W	38.8°C/W

Transistor Count

The transistor count for ICS879S216I-02 is: 1039

Package Outline and Package Dimensions

Package Outline - K Suffix for 24 Lead VFQFN

Bottom View w/Type A ID

CHAMFER △4   N N-1

Bottom View w/Type C ID

RADIUS △4   N N-1
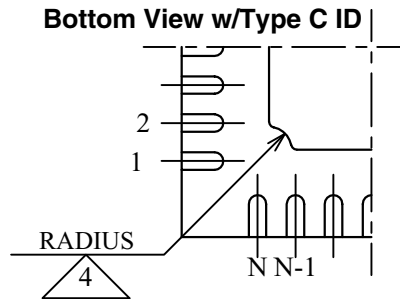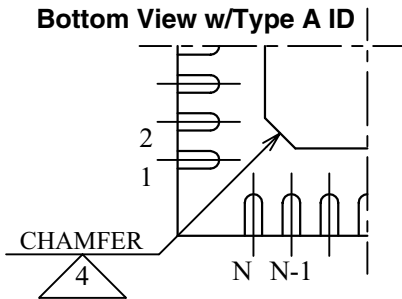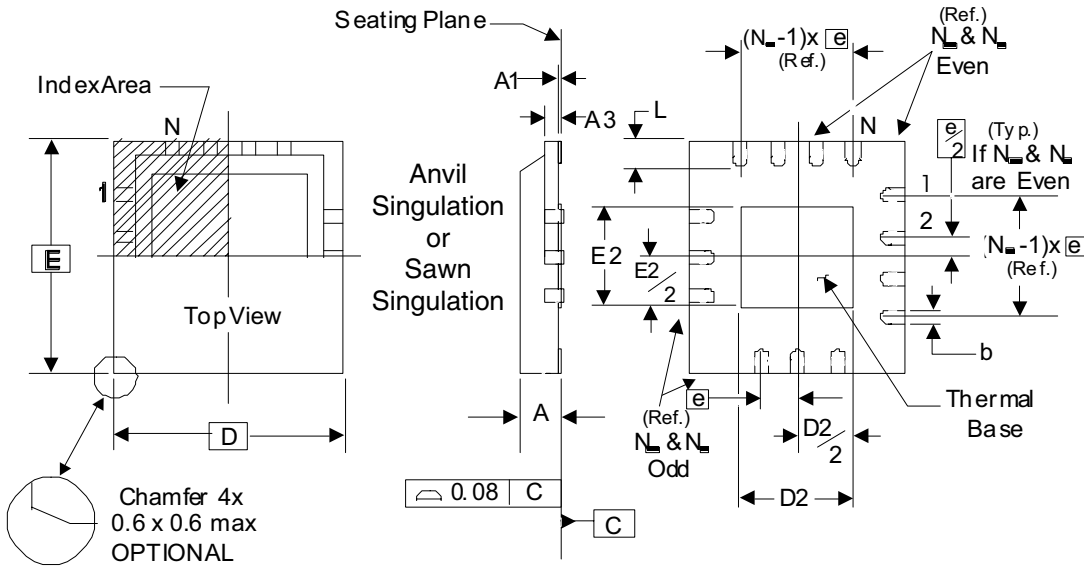
There are 2 methods of indicating pin 1 corner at the back of the VFQFN package are:

1. Type A: Chamfer on the paddle (near pin 1)

2. Type C: Mouse bite on the paddle (near pin 1)

Table 10. Package Dimensions

JEDEC Variation: VEED-2/-4 All Dimensions in Millimeters		
Symbol	**Minimum**	**Maximum**
N	24	
A	0.80	1.0
A1	0	0.05
A3	0.25 Reference	
b	0.18	0.30
e	0.50 Basic	
D, E	4	
D2, E2	2.30	2.55
L	0.30	0.50
N_D N_E	6	

NOTE: The following package mechanical drawing is a generic drawing that applies to any pin count VFQFN package. This drawing is not intended to convey the actual pin count or pin layout of this device. The pin count and pinout are shown on the front page. The package dimensions are in Table 10.

Reference Document: JEDEC Publication 95, MO-220

Ordering Information

Table 11. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
879S216AKI-02LF	6AI02L	"Lead-Free" 24 Lead VFQFN	Tray	-40°C to 85°C
879S216AKI-02LFT	6AI02L	"Lead-Free" 24 Lead VFQFN	2500 Tape & Reel	-40°C to 85°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD-PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers who are designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only to develop an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third-party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising from your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Disclaimer Rev.1.01 Jan 2024)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu,
Koto-ku, Tokyo 135-0061, Japan
www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit www.renesas.com/contact-us/.